

<b>Search Notes</b> 				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/764,092	TOUR ET AL.	
				Examiner	Art Unit	
				Philip H. Leung	3742	
<b>SEARCHED</b>				<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>		
Class	Subclass	Date	Examiner		DATE	EXMR
219	678, 679 702, 761, 715-717 686	3/31/2006	P.L.	EAST searched Inventorship checked Checked copending 10/845,7722 and 10/846,045 and consult Exr. Edna Wong	3/31/2006	re P.L.
204	157.15			EAST searched	6/21/07	re
422	186					
<i>updated 1/8/06 re</i>						
<i>updated 6/21/07 re</i>						
<b>INTERFERENCE SEARCHED</b>						
Class	Subclass	Date	Examiner			